

DATA SHEET

SURFACE-MOUNT CERAMIC MULTILAYER CAPACITORS

High-voltage SC type: NP0/X7R
X1/Y2 & X2
10pF to 56nF



YAGEO

Product Specification – May 21, 2024 V.0



SCOPE

This specification describes safety certification NP0/X7R series chip capacitors with lead-free terminations.

APPLICATIONS

- PCs, Notebook
- Networking
- Power supplies

FEATURES

- Supplied in tape on reel
- Nickel-barrier end termination
- RoHS compliant
- Halogen Free compliant

MARKING

- YSC: Safety Cap
- YST: Safety Cap with Soft-Termination

**ORDERING INFORMATION - GLOBAL PART NUMBER, PHYCOMP****CTC & I2NC**

All part numbers are identified by the series, size, tolerance, TC material, packing style, voltage, process code, termination and capacitance value.

YAGEO BRAND ordering codes**GLOBAL PART NUMBER (PREFERRED)**

XX	xxxx	x	x	xxx	x	B	x	xxx
(1)	(2)	(3)	(4)	(5)	(6)	(7)	(8)	

(1) SERIES

SC : Safety Capacitor

ST : Safety Capacitor with Soft-Termination

(2) SIZE – INCH BASED (METRIC)

1808 (4520)

2211 (5728)

2220 (5750)

(3) TOLERANCE

J = $\pm 5\%$

K = $\pm 10\%$

M = $\pm 20\%$

(4) PACKING STYLE

K = Blister taping reel; Reel 7 inch

(5) TC MATERIAL

NPO

X7R

(6) IMPULSE VOLTAGE

W = X1/Y2 Series for TUV/UL

T = X2 Series for TUV/UL

(7) PROCESS

N = NP0

B = Class 2 product

(8) CAPACITANCE VALUE

2 significant digits+number of zeros

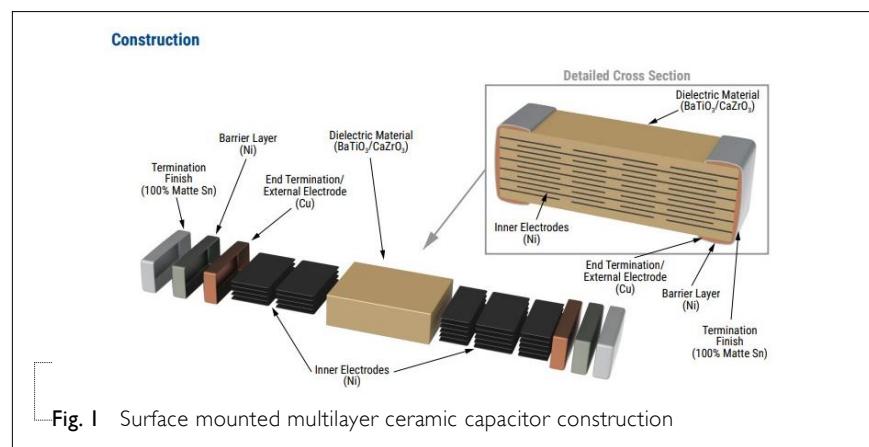
The 3rd digit signifies the multiplying factor, and letter R is decimal point

Example: 121 = $12 \times 10^1 = 120 \text{ pF}$

CONSTRUCTION

The capacitor consists of a rectangular block of ceramic dielectric in which a number of interleaved metal electrodes are contained. This structure gives rise to a high capacitance per unit volume.

The inner electrodes are connected to the two end terminations and finally covered with a layer of plated tin (NiSn). The terminations are lead-free. A cross section of the structure is shown in Fig. I.



DIMENSION

Table I For outlines see fig. 2

TYPE	L1 (MM)	W (MM)	T (MM)	L2 / L3 (MM)		L4 (MM)	DIMENSION CODE
				MIN.	MAX.		
1808	4.5+0.6/-0.3	2.0 ±0.30	1.25 ±0.20	0.25	0.40	4.0	HA
	4.5+0.6/-0.3	2.0 ±0.30	1.6 ±0.20	0.25	0.40	4.0	HC
	4.5+0.6/-0.3	2.0 ±0.30	2.0 ±0.20	0.25	0.40	4.0	HD
	4.5+0.9/-0.3	2.0 ±0.40	1.25 ±0.20	0.25	0.40	4.0	HE
	4.5+0.9/-0.3	2.0 ±0.40	1.6 ±0.20	0.25	0.40	4.0	HG
	4.5+0.9/-0.3	2.0 ±0.40	2.0 ±0.20	0.25	0.40	4.0	HI
2211	5.7 ±0.40	2.8 ±0.30	1.6 ±0.20	0.3	0.75	4.0	GA
	5.7 ±0.40	2.8 ±0.30	2.0 ±0.20	0.3	0.75	4.0	GB
	5.7 ±0.40	2.8 ±0.30	2.5 ±0.30	0.3	0.75	4.0	GC
	5.7 ±0.40	2.8 ±0.30	2.8 ±0.30	0.3	0.75	4.0	GD
	5.7 ±0.50	2.8 ±0.40	1.6 ±0.20	0.3	0.75	4.0	GE
	5.7 ±0.50	2.8 ±0.40	2.0 ±0.20	0.3	0.75	4.0	GF
2220	5.7 ±0.50	2.8 ±0.40	2.5 ±0.30	0.3	0.75	4.0	GG
	5.7 ±0.50	2.8 ±0.40	2.8 ±0.30	0.3	0.75	4.0	GH
	5.7 ±0.40	5.0 ±0.40	2.0 ±0.20	0.3	0.75	4.0	KB
	5.7 ±0.40	5.0 ±0.40	2.5 ±0.30	0.3	0.75	4.0	KC
	5.7 ±0.40	5.0 ±0.40	2.8 ±0.30	0.3	0.75	4.0	KD
	5.7 ±0.50	5.0 ±0.40	2.0 ±0.20	0.3	0.75	4.0	KF
	5.7 ±0.50	5.0 ±0.40	2.5 ±0.30	0.3	0.75	4.0	KG
	5.7 ±0.50	5.0 ±0.40	2.8 ±0.30	0.3	0.75	4.0	KH

OUTLINES

For dimension see Table I

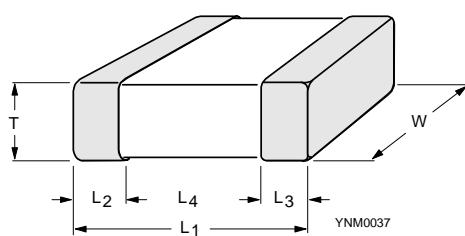


Fig. 2 Surface mounted multilayer ceramic capacitor dimension

CAPACITANCE RANGE & THICKNESS FOR NPO XI/Y2

Table 2 Sizes from 1808

CAP.	SC 1808, NPO	ST 1808, NPO
	XI/Y2	XI/Y2
10 PF	HA	HE
12 PF	HA	HE
15 PF	HA	HE
18 PF	HA	HE
22 PF	HA	HE
27 PF	HC	HG
33 PF	HC	HG
39 PF	HC	HG
47 PF	HC	HG
56 PF	HC	HG
68 PF	HC	HG
82 PF	HC	HG
100 PF	HD	HI
120 PF	HD	HI
150 PF	HD	HI
180 PF	HD	HI
220 PF	HD	HI
270 PF	HD	HI
330 PF	HD	HI
390 PF		
470 PF		

Table 3

CASE SIZE	L (MM)	W (MM)	T (MM)	DIMENSION CODE
1808	4.5+0.6/-0.3	2.0 ±0.30	1.25 ±0.20	HA
	4.5+0.6/-0.3	2.0 ±0.30	1.6 ±0.20	HC
	4.5+0.6/-0.3	2.0 ±0.30	2.0 ±0.20	HD
	4.5+0.9/-0.3	2.0 ±0.40	1.25 ±0.20	HE
	4.5+0.9/-0.3	2.0 ±0.40	1.6 ±0.20	HG
	4.5+0.9/-0.3	2.0 ±0.40	2.0 ±0.20	HI

CAPACITANCE RANGE & THICKNESS FOR X7R X1/Y2 AND X2

Table 4 Sizes from 1808 to 2220

CAP.	SC 1808, X7R X1/Y2	ST 1808, X7R X1/Y2	SC 2211, X7R X1/Y2	ST 2211, X7R X1/Y2	SC 2220, X7R X1/Y2	X2	ST 2220, X7R X1/Y2	X2
100 PF	HC	HG	GA	GE	KB		KF	
120 PF	HC	HG	GA	GE	KB		KF	
150 PF	HC	HG	GA	GE	KB		KF	
180 PF	HC	HG	GA	GE	KB		KF	
220 PF	HC	HG	GA	GE	KB		KF	
270 PF	HD	HI	GA	GE	KB		KF	
330 PF	HD	HI	GA	GE	KB		KF	
390 PF	HD	HI	GA	GE	KB		KF	
470 PF	HD	HI	GB	GF	KB		KF	
560 PF	HD	HI	GB	GF	KB		KF	
680 PF	HD	HI	GB	GF	KB		KF	
820 PF	HD	HI	GB	GF	KB		KF	
1.0 NF	HD	HI	GC	GG	KB		KF	
1.2 NF			GC	GG	KC		KG	
1.5 NF			GC	GG	KC		KG	
1.8 NF			GC	GG	KC		KG	
2.2 NF			GC	GG	KC		KG	
2.7 NF			GD	GH	KC		KG	
3.3 NF					KC		KG	
3.9 NF					KC		KG	
4.7 NF					KC		KG	
5.6 NF								
6.8 NF								
8.2 NF								
10 NF					KC		KG	
12 NF					KC		KG	
15 NF					KC		KG	
18 NF					KC		KG	
22 NF					KD		KH	
27 NF					KD		KH	
33 NF					KD		KH	
39 NF					KD		KH	
47 NF					KD		KH	
56 NF					KD		KH	

Table 5

CASE SIZE	L (MM)	W (MM)	T (MM)	DIMENSION CODE
1808	4.5+0.6/-0.3	2.0 ±0.30	1.25 ±0.20	HA
	4.5+0.6/-0.3	2.0 ±0.30	1.6 ±0.20	HC
	4.5+0.6/-0.3	2.0 ±0.30	2.0 ±0.20	HD
	4.5+0.9/-0.3	2.0 ±0.40	1.25 ±0.20	HE
	4.5+0.9/-0.3	2.0 ±0.40	1.6 ±0.20	HG
	4.5+0.9/-0.3	2.0 ±0.40	2.0 ±0.20	HI
2211	5.7 ±0.40	2.8 ±0.30	1.6 ±0.20	GA
	5.7 ±0.40	2.8 ±0.30	2.0 ±0.20	GB
	5.7 ±0.40	2.8 ±0.30	2.5 ±0.30	GC
	5.7 ±0.40	2.8 ±0.30	2.8 ±0.30	GD
	5.7 ±0.50	2.8 ±0.40	1.6 ±0.20	GE
	5.7 ±0.50	2.8 ±0.40	2.0 ±0.20	GF
2220	5.7 ±0.50	2.8 ±0.40	2.5 ±0.30	GG
	5.7 ±0.50	2.8 ±0.40	2.8 ±0.30	GH
	5.7 ±0.40	5.0 ±0.40	2.0 ±0.20	KB
	5.7 ±0.40	5.0 ±0.40	2.5 ±0.30	KC
	5.7 ±0.40	5.0 ±0.40	2.8 ±0.30	KD
	5.7 ±0.50	5.0 ±0.40	2.0 ±0.20	KF
Safety Certification Capacitor	5.7 ±0.50	5.0 ±0.40	2.5 ±0.30	KG
	5.7 ±0.50	5.0 ±0.40	2.8 ±0.30	KH

THICKNESS CLASSES AND PACKING QUANTITY

Table 6

DESCRIPTION	SIZE CODE	THICKNESS CLASSIFICATION (mm)	12 mm TAPE WIDTH /AMOUNT PER REEL Ø180 mm, 7" Blister
1808		1.25 ±0.20	3,000
		1.6 ±0.20	2,000
		2.0 ±0.20	2,000
2211		1.6 ±0.20	1,000
		2.0 ±0.20	1,000
		2.5 ±0.30	500
2220		2.8 ±0.30	500
		2.0 ±0.20	1,000
		2.5 ±0.30	500
		2.8 ±0.30	500

ELECTRICAL CHARACTERISTICS**NP0/X7R DIELECTRIC CAPACITORS; NISN TERMINATIONS**

Unless otherwise stated all electrical values apply at an ambient temperature of 20 ± 1 °C, an atmospheric pressure of 86 to 106 kPa, and a relative humidity of 63 to 67%.

Table 7

DESCRIPTION		VALUE
Capacitance range		10pF to 56nF
Capacitance tolerance		
NP0	$C < 10$ pF	± 0.25 pF, ± 0.5 pF
	$C \geq 10$ pF	$\pm 5\%$
X7R		$\pm 10\%$
Dissipation factor (D.F.)		
NP0	$C < 30$ pF	$\leq 1 / (400 + 20C)$
	$C \geq 30$ pF	$\leq 0.1\%$
X7R		$\leq 2.5\%$
Insulation resistance after 1 minute at U_r (DC)		$R_{ins} \geq 10$ GΩ or $R_{ins} \times C \geq 500$ seconds whichever is less
Maximum capacitance change as a function of temperature (temperature characteristic/coeffcient):		
NP0		± 30 ppm/°C
X7R		$\pm 15\%$
Operating temperature range: NP0/X7R		-55 °C to +125 °C

CAPACITOR REQUIREMENT

Table 8

SAFETY RATING	VOLTAGE RATING	WITHSTANDING VOLTAGE	IMPULSE VOLTAGE
X1	250 VAC	1,500 VAC	4,000 V
X2	250 VAC	1,500 VAC	2,500 V
Y2	250 VAC	1,500 VAC	5,000 V

SOLDERING RECOMMENDATION

Table 9

SOLDERING METHOD	SIZE 0402	0603	0805	1206	≥ 1210
Reflow	$\geq 0.1\mu F$	$\geq 1.0\mu F$	$\geq 2.2\mu F$	$\geq 4.7\mu F$	Reflow only
Reflow/Wave	$< 0.1\mu F$	$< 1.0\mu F$	$< 2.2\mu F$	$< 4.7\mu F$	---

TESTS AND REQUIREMENTS

Table 10 Test procedures and requirements

TEST	TEST METHOD	PROCEDURE	REQUIREMENTS
Mounting	IEC 60384- 21/22	4.3 The capacitors may be mounted on printed-circuit boards or ceramic substrates	No visible damage
Visual Inspection and Dimension Check	4.4	Any applicable method using $\times 10$ magnification	In accordance with specification
Capacitance	4.5.1	NP0: $f = 1 \text{ MHz}$ for $C \leq 1 \text{ nF}$, measuring at voltage 1 V_{rms} at 20°C ; $f = 1 \text{ KHz}$ for $C > 1 \text{ nF}$, measuring at voltage 1 V_{rms} at 20°C X7R: $f = 1 \text{ KHz}$ for $C \leq 10 \mu\text{F}$, measuring at voltage 1 V_{rms} at 20°C	Within specified tolerance
Dissipation Factor (D.F.)	4.5.2	NP0: $f = 1 \text{ MHz}$ for $C \leq 1 \text{ nF}$, measuring at voltage 1 V_{rms} at 20°C ; $f = 1 \text{ KHz}$ for $C > 1 \text{ nF}$, measuring at voltage 1 V_{rms} at 20°C X7R: $f = 1 \text{ KHz}$ for $C \leq 10 \mu\text{F}$, measuring at voltage 1 V_{rms} at 20°C	In accordance with specification
Insulation Resistance	4.5.3	To apply 500 V max for 60 seconds	In accordance with specification

TEST	TEST METHOD	PROCEDURE	REQUIREMENTS												
Temperature Characteristic	4.6	<p>Capacitance shall be measured by the steps shown in the following table.</p> <p>The capacitance change should be measured after 5 min at each specified temperature stage.</p> <table border="1"> <thead> <tr> <th>Step</th><th>Temperature(°C)</th></tr> </thead> <tbody> <tr> <td>a</td><td>25±2</td></tr> <tr> <td>b</td><td>Lower temperature±3°C</td></tr> <tr> <td>c</td><td>25±2</td></tr> <tr> <td>d</td><td>Upper Temperature±2°C</td></tr> <tr> <td>e</td><td>25±2</td></tr> </tbody> </table> <p>(1) Class I</p> <p>Temperature Coefficient shall be calculated from the formula as below</p> $\text{Temp, Coefficient} = \frac{C2 - C1}{C1 \times \Delta T} \times 10^6 \text{ [ppm/°C]}$ <p>C1: Capacitance at step c C2: Capacitance at 125°C ΔT: 100°C (=125°C -25°C)</p> <p>(2) Class II</p> <p>Capacitance Change shall be calculated from the formula as below</p> $\Delta C = \frac{C2 - C1}{C1} \times 100\%$ <p>C1: Capacitance at step c C2: Capacitance at step b or d</p>	Step	Temperature(°C)	a	25±2	b	Lower temperature±3°C	c	25±2	d	Upper Temperature±2°C	e	25±2	<p>Class1: $\Delta C/C: \pm 30\text{ppm}$</p> <p>Class2: X7R: $\Delta C/C: \pm 15\%$</p>
Step	Temperature(°C)														
a	25±2														
b	Lower temperature±3°C														
c	25±2														
d	Upper Temperature±2°C														
e	25±2														
Adhesion	4.15	<p>a. A force applied for 10 seconds to the line joining the terminations and in a plane parallel to the substrate for size \geq 0603 : a force of 5N applied</p> <p>b. A force applied until broken For size \geq 0603: \geq 5N</p>	No visible damage												
Bond Strength of Plating on End Face	IEC 60384-21/22	<p>4.8 Mounting in accordance with IEC 60384-22 paragraph 4.3</p> <p>Conditions: bending 1 mm at a rate of 1 mm/s, radius jig 340 mm</p>	<p>No visible damage</p> <p>$\Delta C/C$ NP0: $\leq 1\%$ or 0.5 pF whichever is greater X7R: $\leq 10\%$</p>												
Resistance to Soldering Heat	4.9	<p>Precondition: $150 +0/-10$ °C for 1 hour, then keep for 24 ± 1 hours at room temperature</p> <p>Preheating: for size \leq 1206: 120 °C to 150 °C for 1 minute</p> <p>Preheating: for size > 1206: 100 °C to 120 °C for 1 minute and 170 °C to 200 °C for 1 minute</p> <p>Solder bath temperature: 260 ± 5 °C</p> <p>Dipping time: 10 ± 0.5 seconds</p> <p>Recovery time: 24 ± 2 hours</p>	<p>The termination shall be well tinned</p> <p>$\Delta C/C$ NP0: $\leq 0.5\%$ or 0.5 pF whichever is greater X7R: $\leq 10\%$</p> <p>D.F. within initial specified value R_{ins} within initial specified value</p>												

TEST	TEST METHOD	PROCEDURE	REQUIREMENTS
Solderability	4.10	Unmounted chips completely immersed in a solder bath at 235 ± 5 °C Dipping time: 2 ± 0.5 seconds Depth of immersion: 10 mm	The termination shall be well tinned
Damp Heat with U_r Load	4.13	Initial measurements; after $150 +0/-10$ °C for 1 hour, then keep for 24 ± 1 hours at room temperature Duration and conditions: 500 ± 12 hours at 40 ± 2 °C; 90 to 95% RH; $1.0 U_r$ applied Final measurement: perform a heat treatment at $150 +0/-10$ °C for 1 hour, final measurements shall be carried out 24 ± 1 hours after recovery at room temperature without load	$\Delta C/C$ NP0: $\leq 2\%$ or 1 pF whichever is greater X7R: $\leq 15\%$ D.F. NP0: $\leq 2 \times$ specified value X7R: $\geq 100V: \leq 5\%$ Rins NP0: $\geq 2,500 \text{ M}\Omega$ or Rins $\times Cr \geq 25s$ whichever is less X7R: $\geq 500 \text{ M}\Omega$ or Rins $\times Cr \geq 25s$ whichever is less
Endurance	EN132400 4.14 SC	Perform shear test, substrate bending test, impulse voltage and then endurance test progressively Same as the above except for $1.25 U_r$ for X-capacitor and $1.7 U_r$ for Y-capacitor Once every hour the voltage shall be increased to 1000 VAC for 0.1 s Total time take to change over to 1000 VAC and back does not exceed 30 s	Visual examination $DC/C < \pm 20\%$ Voltage proof $IR > 3 \times 10^9 \Omega$
Impulse Voltage	4.13 SC IEC-60384-14	X1: 4.0 KV, X2: 2.5 KV Y2: 5.0 KV, Y3: None If any three successive impulses are shown by the oscilloscope monitor to have had a waveform indicating that no self-healing breakdowns or flashovers have taken place in the capacitor, then no further impulses shall be applied and the capacitor shall be counted as conforming. 24 impulses have been applied to the capacitor and 3 or more of them are of a waveform indicating that no self-healing breakdowns or flashovers have occurred. Time between impulses shall not be less than 10 s	No breakdown or flashover
Robustness of Termination (Pull Strength)	4.3 SC	a. A force applied for 10 sec to the line joining the terminations and in a plane parallel to the substrate. b. A force applied until broken	a. No visible damage b. Force size $\geq 0603: \geq 5N$
Voltage Proof	4.2.1 SC	X capacitor: Applied voltage 1.075K VDC ($4.3 U_r$) Y capacitor: Applied voltage 1.5K VAC	No breakdown or flashover

REVISION HISTORY

REVISION	DATE	CHANGE NOTIFICATION	DESCRIPTION
Version 0	May 21, 2024	-	- New datasheet for high voltage NP0/X7R series with lead-free terminations

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